TABLE OF CONTENTS

Features
Applications1
General Description 1
Functional Block Diagram 1
Revision History 2
Specifications
Test Conditions
Analog Performance Specifications
Crystal Oscillator Specifications4
Digital Input/Output Specifications5
Power Supply Specifications5
Digital Filters
Timing Specifications7
Absolute Maximum Ratings
Thermal Resistance
ESD Caution
Pin Configuration and Function Descriptions9
Typical Performance Characteristics11
Theory of Operation

REVISION HISTORY

2/13—Rev. D to Rev. E	
Change to t _{CLH} Parameter, Table 7	7

7/11—Rev. C to Rev. D

Changes to Table 10, DSDATAx/ASDATAx Pin Descriptions...9

1/11-Rev. B to Rev. C

Added Automotive Information	Throughout
Change to Table 2, Introductory Text	
Change to Table 4, Introductory Text	
Change to Table 7, Introductory Text	7
Changes to Ordering Guide	

8/09—Rev. A to Rev. B

Changes to Table 16 Title	24
Changes to Figure 18 and Table 19 Titles	25
Changes to Table 20 Title	26
Changes to Table 23 and Table 24 Titles	27
Changes to Table 25 Title	28
Changes to Ordering Guide	31

I	Analog-to-Digital Converters (ADCs)	13
Ι	Digital-to-Analog Converters (DACs)	13
(Clock Signals	13
I	Reset and Power-Down	14
5	Serial Control Port	14
I	Power Supply and Voltage Reference	15
5	Serial Data Ports—Data Format	15
1	Гime-Division Multiplexed (TDM) Modes	15
Ι	Daisy-Chain Mode	19
Co	ntrol Registers	24
Co	ntrol Registers Definitions	24 24
Co. I I	ntrol Registers Definitions PLL and Clock Control Registers	24 24 24
Co. I H I	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers	24 24 24 25
Co. I I I	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers ADC Control Registers	24 24 24 25 27
Co. I I I I	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers ADC Control Registers Additional Modes	24 24 25 27 29
Co. I I I I Ap	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers ADC Control Registers Additional Modes plications Circuits	24 24 25 27 29 30
Co I I I I Ap Ou	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers ADC Control Registers Additional Modes plications Circuits	24 24 25 27 29 30 31
Co. I H I I Ap Ou	ntrol Registers Definitions PLL and Clock Control Registers DAC Control Registers ADC Control Registers Additional Modes plications Circuits tline Dimensions Ordering Guide	24 24 25 27 29 30 31 31

7/08-Rev. 0 to Rev. A

Changes to Table 7	7
Changes to Figure 2	9
Changes to Table 10	9
Changes to Clock Signals Section	13
Changes to Reset and Power-Down Section	14
Change to Serial Control Port Section	14
Changes to Table 11	14
Changes to Figure 24 and Figure 25	22
Changes to Figure 26	
Changes to Definitions Section	
Changes to Table 16	
Change to Additional Modes Section	
Change to Figure 30	30
• •	

5/06—Revision 0: Initial Version

SPECIFICATIONS

TEST CONDITIONS

Performance of all channels is identical, exclusive of the interchannel gain mismatch and interchannel phase deviation specifications.

Supply voltages (AVDD, DVDD)	3.3 V
Temperature range ¹	as specified in Table 1 and Table 2
Master clock	12.288 MHz (48 kHz fs, 256 \times fs mode)
Input sample rate	48 kHz
Measurement bandwidth	20 Hz to 20 kHz
Word width	24 bits
Load capacitance (digital output)	20 pF
Load current (digital output)	$\pm 1~\text{mA}$ or 1.5 k Ω to ½ DVDD supply
Input voltage high	2.0 V
Input voltage low	0.8 V

 1 Functionally guaranteed at –40°C to +125°C case temperature.

ANALOG PERFORMANCE SPECIFICATIONS

Specifications guaranteed at an ambient temperature of 25°C.

Table 1.

Parameter	Conditions	Min	Тур	Max	Unit
ANALOG-TO-DIGITAL CONVERTERS					
ADC Resolution	All ADCs		24		Bits
Dynamic Range	20 Hz to 20 kHz, –60 dB input				
No Filter (RMS)		98	102		dB
With A-Weighted Filter (RMS)		100	105		dB
Total Harmonic Distortion + Noise	–1 dBFS		-96	-87	dB
Full-Scale Input Voltage (Differential)			1.9		V rms
Gain Error		-10		+10	%
Interchannel Gain Mismatch		-0.25		+0.25	dB
Offset Error		-10	0	+10	mV
Gain Drift			100		ppm/°C
Interchannel Isolation			-110		dB
CMRR	100 mV rms, 1 kHz		55		dB
	100 mV rms, 20 kHz		55		dB
Input Resistance			14		kΩ
Input Capacitance			10		pF
Input Common-Mode Bias Voltage			1.5		V
DIGITAL-TO-ANALOG CONVERTERS					
Dynamic Range	20 Hz to 20 kHz, –60 dB input				
No Filter (RMS)		98	104		dB
With A-Weighted Filter (RMS)		100	106		dB
With A-Weighted Filter (Average)			108		dB
Total Harmonic Distortion + Noise	0 dBFS				
Single-Ended Version	Two channels running		-92		dB
Single-Ended Version	Eight channels running		-86	-75	dB
Full-Scale Output Voltage			0.88 (2.48)		V rms (V p-p)
Gain Error		-10		+10	%
Interchannel Gain Mismatch		-0.2		+0.2	dB
Offset Error		-25	-4	+25	mV
Gain Drift		-30		+30	ppm/°C

Parameter	Conditions	Min	Тур	Мах	Unit
Interchannel Isolation			100		dB
Interchannel Phase Deviation			0		Degrees
Volume Control Step			0.375		dB
Volume Control Range			95		dB
De-emphasis Gain Error				±0.6	dB
Output Resistance at Each Pin			100		Ω
REFERENCE					
Internal Reference Voltage	FILTR pin		1.50		V
External Reference Voltage	FILTR pin	1.32	1.50	1.68	V
Common-Mode Reference Output	CM pin		1.50		V

Specifications measured at a case temperature of 125°C.

Table 2.					
Parameter	Conditions	Min	Тур	Max	Unit
ANALOG-TO-DIGITAL CONVERTERS					
ADC Resolution	All ADCs		24		Bits
Dynamic Range	20 Hz to 20 kHz, –60 dB input				
No Filter (RMS)		95	102		dB
With A-Weighted Filter (RMS)		97	105		dB
Total Harmonic Distortion + Noise	-1 dBFS		-96	-87	dB
Full-Scale Input Voltage (Differential)			1.9		V rms
Gain Error		-10		+10	%
Interchannel Gain Mismatch		-0.25		+0.25	dB
Offset Error		-10	0	+10	mV
DIGITAL-TO-ANALOG CONVERTERS					
Dynamic Range	20 Hz to 20 kHz, –60 dB input				
No Filter (RMS)		98	104		dB
With A-Weighted Filter (RMS)		100	106		dB
With A-Weighted Filter (Average)			108		dB
Total Harmonic Distortion + Noise	0 dBFS				
Single-Ended Version	Two channels running		-92		dB
Single-Ended Version	Eight channels running		-86	-70	dB
Full-Scale Output Voltage			0.8775 (2.482)		V rms (V p-p)
Gain Error		-10		+10	%
Interchannel Gain Mismatch		-0.2		+0.2	dB
Offset Error		-25	-4	25	mV
Gain Drift		-30		30	ppm/°C
REFERENCE					
Internal Reference Voltage	FILTR pin		1.50		V
External Reference Voltage	FILTR pin	1.32	1.50	1.68	V
Common-Mode Reference Output	CM pin		1.50		V

CRYSTAL OSCILLATOR SPECIFICATIONS

Table 3.

Parameter	Min	Тур	Max	Unit
Transconductance		3.5		mmhos

DIGITAL INPUT/OUTPUT SPECIFICATIONS

 $-40^{o}C < T_{C} < +125^{o}C, \ DVDD = 3.3 \ V \pm 10\%.$

Table 4.

Parameter	Conditions/Comments	Min	Тур	Max	Unit
High Level Input Voltage (V⊮)		2.0			V
High Level Input Voltage (V⊮)	MCLKI/XI pin	2.2			V
Low Level Input Voltage (V _{IL})				0.8	V
Input Leakage	$I_{IH} @ V_{IH} = 2.4 V$			10	μA
	$I_{IL} @ V_{IL} = 0.8 V$			10	μΑ
High Level Output Voltage (V _{OH})	I _{он} = 1 mA	DVDD - 0.60			V
Low Level Output Voltage (Vol)	$I_{OL} = 1 \text{ mA}$			0.4	V
Input Capacitance				5	pF

POWER SUPPLY SPECIFICATIONS

Table 5.

Parameter	Conditions/Comments	Min	Тур	Max	Unit
SUPPLIES					
Voltage	DVDD	3.0	3.3	3.6	V
	AVDD	3.0	3.3	3.6	V
Digital Current	Master clock = $256 f_s$				
Normal Operation	$f_s = 48 \text{ kHz}$		56		mA
	f _s = 96 kHz		65		mA
	$f_s = 192 \text{ kHz}$		95		mA
Power-Down	$f_s = 48 \text{ kHz}$ to 192 kHz		2.0		mA
Analog Current					
Normal Operation			74		mA
Power-Down			23		mA
DISSIPATION					
Operation	Master clock = 256 fs, 48 kHz				
All Supplies			429		mW
Digital Supply			185		mW
Analog Supply			244		mW
Power-Down, All Supplies			83		mW
POWER SUPPLY REJECTION RATIO					
Signal at Analog Supply Pins	1 kHz, 200 mV p-p		50		dB
	20 kHz, 200 mV p-p		50		dB

DIGITAL FILTERS

Table 6.

Parameter	Mode	Factor	Min	Тур	Max	Unit
ADC DECIMATION FILTER	All modes, typical @ 48 kHz					
Pass Band		0.4375 fs		21		kHz
Pass-Band Ripple				±0.015		dB
Transition Band		0.5 fs		24		kHz
Stop Band		0.5625 fs		27		kHz
Stop-Band Attenuation			79			dB
Group Delay		22.9844/fs		479		μs
DAC INTERPOLATION FILTER						
Pass Band	48 kHz mode, typical @ 48 kHz	0.4535 fs		22		kHz
	96 kHz mode, typical @ 96 kHz	0.3646 fs	35			kHz
	192 kHz mode, typical @ 192 kHz	0.3646 fs		70		kHz
Pass-Band Ripple	48 kHz mode, typical @ 48 kHz				±0.01	dB
	96 kHz mode, typical @ 96 kHz				±0.05	dB
	192 kHz mode, typical @ 192 kHz				±0.1	dB
Transition Band	48 kHz mode, typical @ 48 kHz	0.5 fs		24		kHz
	96 kHz mode, typical @ 96 kHz	0.5 fs		48		kHz
	192 kHz mode, typical @ 192 kHz	0.5 fs		96		kHz
Stop Band	48 kHz mode, typical @ 48 kHz	0.5465 fs		26		kHz
	96 kHz mode, typical @ 96 kHz	0.6354 fs		61		kHz
	192 kHz mode, typical @ 192 kHz	0.6354 fs		122		kHz
Stop-Band Attenuation	48 kHz mode, typical @ 48 kHz		70			dB
	96 kHz mode, typical @ 96 kHz		70			dB
	192 kHz mode, typical @ 192 kHz		70			dB
Group Delay	48 kHz mode, typical @ 48 kHz	25/fs		521		μs
	96 kHz mode, typical @ 96 kHz	11/fs		115		μs
	192 kHz mode, typical @ 192 kHz	8/fs		42		μs

TIMING SPECIFICATIONS

 $-40^{\circ}C < T_{C} < +125^{\circ}C$, DVDD = 3.3 V ± 10%.

Table 7.

Parameter	Condition	Comments	Min	Max	Unit
INPUT MASTER CLOCK (MCLK) AND RESET					
t _{MH}	MCLK duty cycle	DAC/ADC clock source = PLL clock @ 256 fs, 384 fs, 512 fs, and 768 fs	40	60	%
tмн		DAC/ADC clock source = direct MCLK @ 512 fs (bypass on-chip PLL)	40	60	%
fmcik	MCLK frequency	PLL mode, 256 fs reference	6.9	13.8	MHz
fmcik		Direct 512 fs mode		27.6	MHz
t _{PDB}	RST low		15		ns
tporr	RST recovery	Reset to active output	4096		tмсік
PLI					incent
Lock time	MCLK and LR clock input			10	ms
256 fs VCO Clock Output Duty Cycle	Meen and En clock input		40	60	%
MCLKO/XO Pin			-10	00	70
SPI PORT		See Figure 11			
t _{CCH}	CCLK high		35		ns
tccl	CCLK low		35		ns
fcclk	CCLK frequency	$f_{CCLK} = 1/t_{CCP}$, only t_{CCP} shown in Figure 11		10	MHz
tcps	CIN setup	To CCLK rising	10		ns
t _{CDH}	CIN hold	From CCLK rising	10		ns
tas	CLATCH setup	To CCLK rising	10		ns
tан	CLATCH hold	From CCI K rising	10		ns
tau		Not shown in Figure 11	10		ns
tsos	COUTenable	From CCLK falling	10	30	ns
tcoe		From CCLK falling		20	115 DC
too		From CCLK falling	30	50	ns
	COUT tristato	From CCLK falling	30	30	ns
		See Figure 24		50	115
	DPCLKhigh	See Figure 24	10		nc
tDBH t	DBCLK IIIgIT	Slave mode	10		ns
	DI PCI K sotup	To DBCLK rising, slave mode	10		nc
tous	DI BCI K bold	From DBCLK rising, slave mode	5		ns
	DI PCI K skow	From DBCLK falling, master mode	2	1.9	nc
tors	DSDATA setup	To DBCLK rising	10	+0	ns
	DSDATA bold	From DBCLK rising	5		ns
		Soo Figure 25	5		113
	ABCI K high	Slave mode	10		nc
	ABCI K low	Slave mode	10		nc
	AL RCLK setup	To ABCLK rising slave mode	10		ns
tals	ALRELK bold	From ABCLK rising, slave mode	5		nc
	ALINCLIK NOID	From ABCLK falling, master mode	_8	⊥8	ns
	ASDATA delay	From ABCLK falling	-0	18	ns
	ASDAIA delay			10	115
		To ALLYBCLK rising	10		nc
taxbs			5		ns
			5	19	nc
	ALIXECI K high		10	10	ns
•ХВМ Турі			10		ns
	ALIXI RCI K setun	To ALIXBCLK rising	10		ns
	ALIXI RCI K hold		5		nç
•ULN	, overcention	1.6.1. AOADCERTIBILIS	2		

ABSOLUTE MAXIMUM RATINGS

Table 8.

Parameter	Rating
Analog (AVDD)	–0.3 V to +3.6 V
Digital (DVDD)	–0.3 V to +3.6 V
Input Current (Except Supply Pins)	±20 mA
Analog Input Voltage (Signal Pins)	–0.3 V to AVDD + 0.3 V
Digital Input Voltage (Signal Pins)	–0.3 V to DVDD + 0.3 V
Operating Temperature Range (Case)	-40°C to +125°C
Storage Temperature Range	–65°C to +150°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

 θ_{JA} represents thermal resistance, junction-to-ambient; θ_{JC} represents the thermal resistance, junction-to-case. All characteristics are for a 4-layer board.

Table 9. Thermal Resistance

Package Type	θ _{JA}	θ _{JC}	Unit
48-Lead LQFP	50.1	17	°C/W

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 2. Pin Configuration, 48-Lead LQFP

Table 10. Pin Function Descriptions

		^	
Pin No.	In/Out	Mnemonic	Description
1	I	AGND	Analog Ground.
2	I	MCLKI/XI	Master Clock Input/Crystal Oscillator Input.
3	0	MCLKO/XO	Master Clock Output/Crystal Oscillator Output.
4	I	AGND	Analog Ground.
5	1	AVDD	Analog Power Supply. Connect to analog 3.3 V supply.
6	0	OL3	DAC 3 Left Output.
7	0	OR3	DAC 3 Right Output.
8	0	OL4	DAC 4 Left Output.
9	0	OR4	DAC 4 Right Output.
10	I	PD/RST	Power-Down Reset (Active Low).
11	I/O	DSDATA4	DAC Serial Input 4. Data input to DAC4 data in/TDM DAC2 data out (dual-line mode)/AUX DAC2 data out (to external DAC2).
12	1	DGND	Digital Ground.
13	1	DVDD	Digital Power Supply. Connect to digital 3.3 V supply.
14	I/O	DSDATA3	DAC Serial Input 3. Data input to DAC3 data in/TDM DAC2 data in (dual-line mode)/AUX ADC2 data in (from external ADC2).
15	I/O	DSDATA2	DAC Serial Input 2. Data input to DAC2 data in/TDM DAC data out/AUX ADC1 data in (from external ADC1).
16	I	DSDATA1	DAC Serial Data Input 1. Data input to DAC1 data in/TDM DAC data in/TDM data in.
17	I/O	DBCLK	Bit Clock for DACs.
18	I/O	DLRCLK	LR Clock for DACs.
19	I/O	ASDATA2	ADC Serial Data Output 2. Data output from ADC2/TDM ADC data in/AUX DAC1 data out (to external DAC1).
20	0	ASDATA1	ADC Serial Data Output 1. Data output from ADC1/TDM ADC data out/TDM data out.
21	I/O	ABCLK	Bit Clock for ADCs.
22	I/O	ALRCLK	LR Clock for ADCs.
23	I	CIN	Control Data Input (SPI).
24	I/O	COUT	Control Data Output (SPI).
25	I	DGND	Digital Ground.

Pin No.	In/Out	Mnemonic	Description
26	1	CCLK	Control Clock Input (SPI).
27	I	CLATCH	Latch Input for Control Data (SPI).
28	0	OL1	DAC 1 Left Output.
29	0	OR1	DAC 1 Right Output.
30	0	OL2	DAC 2 Left Output.
31	0	OR2	DAC 2 Right Output.
32	1	AGND	Analog Ground.
33	1	AVDD	Analog Power Supply. Connect to analog 3.3 V supply.
34	I	AGND	Analog Ground.
35	0	FILTR	Voltage Reference Filter Capacitor Connection. Bypass with 10 μ F 100 nF to AGND.
36	I	AGND	Analog Ground.
37	1	AVDD	Analog Power Supply. Connect to analog 3.3 V supply.
38	0	СМ	Common-Mode Reference Filter Capacitor Connection. Bypass with 47 μ F 100 nF to AGND.
39	I	ADC1LP	ADC1 Left Positive Input.
40	I	ADC1LN	ADC1 Left Negative Input.
41	I	ADC1RP	ADC1 Right Positive Input.
42	I	ADC1RN	ADC1 Right Negative Input.
43	I	ADC2LP	ADC2 Left Positive Input.
44	I	ADC2LN	ADC2 Left Negative Input.
45	I	ADC2RP	ADC2 Right Positive Input.
46	I	ADC2RN	ADC2 Right Negative Input.
47	0	LF	PLL Loop Filter, Return to AVDD.
48	1	AVDD	Analog Power Supply. Connect to analog 3.3 V supply.

TYPICAL PERFORMANCE CHARACTERISTICS



Figure 5. DAC Pass-Band Filter Response, 48 kHz



Figure 6. DAC Stop-Band Filter Response, 48 kHz



Figure 7. DAC Pass-Band Filter Response, 96 kHz



Figure 8. DAC Stop-Band Filter Response, 96 kHz





Figure 10. DAC Stop-Band Filter Response, 192 kHz

THEORY OF OPERATION ANALOG-TO-DIGITAL CONVERTERS (ADCS)

There are four ADC channels in the AD1938 configured as two stereo pairs with differential inputs. The ADCs can operate at a nominal sample rate of 48 kHz, 96 kHz, or 192 kHz. The ADCs include on-board digital antialiasing filters with 79 dB stopband attenuation and linear phase response, operating at an oversampling ratio of 128 (48 kHz, 96 kHz, and 192 kHz modes). Digital outputs are supplied through two serial data output pins (one for each stereo pair) and a common frame clock (ALRCLK) and bit clock (ABCLK). Alternatively, one of the TDM modes can be used to access up to 16 channels on a single TDM data line.

The ADCs must be driven from a differential signal source for best performance. The input pins of the ADCs connect to internal switched capacitors. To isolate the external driving op amp from the glitches caused by the internal switched capacitors, each input pin should be isolated by using a series connected, external, 100 Ω resistor together with a 1 nF capacitor connected from each input to ground. This capacitor must be of high quality, for example, ceramic NPO or polypropylene film.

The differential inputs have a nominal common-mode voltage of 1.5 V. The voltage at the common-mode reference pin (CM) can be used to bias external op amps to buffer the input signals (see the Power Supply and Voltage Reference section). The inputs can also be ac-coupled and do not need an external dc bias to CM.

A digital high-pass filter can be switched in line with the ADCs under serial control to remove residual dc offsets. It has a 1.4 Hz, 6 dB per octave cutoff at a 48 kHz sample rate. The cutoff frequency scales directly with sample frequency.

DIGITAL-TO-ANALOG CONVERTERS (DACS)

The AD1938 DAC channels are arranged as single-ended, four stereo pairs giving eight analog outputs for minimum external components. The DACs include on-board digital reconstruction filters with 70 dB stop-band attenuation and linear phase response, operating at an oversampling ratio of 4 (48 kHz or 96 kHz modes) or 2 (192 kHz mode). Each channel has its own independently programmable attenuator, adjustable in 255 steps in increments of 0.375 dB. Digital inputs are supplied through four serial data input pins (one for each stereo pair), a common frame clock (DLRCLK), and a bit clock (DBCLK). Alternatively, one of the TDM modes can be used to access up to 16 channels on a single TDM data line.

Each output pin has a nominal common-mode dc level of 1.5 V and swings $\pm 1.27 \text{ V}$ for a 0 dBFS digital input signal. A single op amp, third-order, external, low-pass filter is recommended to remove high frequency noise present on the output pins. The use of op amps with low slew rate or low bandwidth can cause high frequency noise and tones to fold down into the audio band; therefore, exercise care in selecting these components.

The voltage at CM, the common-mode reference pin, can be used to bias the external op amps that buffer the output signals (see the Power Supply and Voltage Reference section).

CLOCK SIGNALS

The on-chip phase locked loop (PLL) can be selected to reference the input sample rate from either of the LRCLK pins or 256, 384, 512, or 768 times the sample rate, referenced to the 48 kHz mode from the MCLKI/XI pin. The default at power-up is $256 \times f_s$ from the MCLKI/XI pin. In 96 kHz mode, the master clock frequency stays at the same absolute frequency; therefore, the actual multiplication rate is divided by 2. In 192 kHz mode, the frequency of the master clock input is $256 \times f_s$ mode, the frequency of the master clock input is 256×48 kHz = 12.288 MHz. If the AD193x is then switched to 96 kHz operation (by writing to the SPI port), the frequency of the master clock should remain at 12.288 MHz, which becomes $128 \times f_s$. In 192 kHz mode, this becomes $64 \times f_s$.

The internal clock for the ADCs is $256 \times f_s$ for all clock modes. The internal clock for the DACs varies by mode: $512 \times f_s$ (48 kHz mode), $256 \times f_s$ (96 kHz mode), or $128 \times f_s$ (192 kHz mode). By default, the on-board PLL generates this internal master clock from an external clock. A direct $512 \times f_s$ (referenced to 48 kHz mode) master clock can be used for either the ADCs or DACs if selected in the PLL and Clock Control 1 register.

Note that it is not possible to use a direct clock for the ADCs set to the 192 kHz mode. It is required that the on-chip PLL be used in this mode.

The PLL can be powered down in the PLL and Clock Control 0 register. To ensure reliable locking when changing PLL modes, or if the reference clock is unstable at power-on, power down the PLL and then power it back up when the reference clock stabilizes.

The internal master clock can be disabled in the PLL and Clock Control 0 register to reduce power dissipation when the AD1938 is idle. The clock should be stable before it is enabled. Unless a standalone mode is selected (see the Serial Control Port section), the clock is disabled by reset and must be enabled by writing to the SPI port for normal operation.

To maintain the highest performance possible, limit the clock jitter of the internal master clock signal to less than a 300 ps rms time interval error (TIE). Even at these levels, extra noise or tones can appear in the DAC outputs if the jitter spectrum contains large spectral peaks. If the internal PLL is not used, it is best to use an independent crystal oscillator to generate the master clock. In addition, it is especially important that the clock signal not pass through an FPGA, CPLD, or other large digital chip (such as a DSP) before being applied to the AD1938. In most cases, this induces clock jitter due to the sharing of common power and ground connections with other unrelated digital output signals. When the PLL is used, jitter in

the reference clock is attenuated above a certain frequency depending on the loop filter.

RESET AND POWER-DOWN

The function of the $\overline{\text{RST}}$ pin sets all the control registers to their default settings. To avoid pops, reset does not power down the analog outputs. After $\overline{\text{RST}}$ is deasserted, and the PLL acquires lock condition, an initialization routine runs inside the AD1938. This initialization lasts for approximately 256 master clock cycles.

The power-down bits in the PLL and Clock Control 0, DAC Control 1, and ADC Control 1 registers power down the respective sections. All other register settings are retained. To guarantee proper start up, the RST pin should be pulled low by an external resistor.

SERIAL CONTROL PORT

The AD1938 has an SPI control port that permits programming and reading back of the internal control registers for the ADCs, DACs, and clock system. There is also a standalone mode available for operation without serial control that is configured

Table 11. Standalone Mode Selection

at reset using the serial control pins. All registers are set to default, except the internal master clock enable which is set to 1, and ADC BCLK and LRCLK master/slave is set by the COUT pin. Refer to Table 11 for details. Standalone mode only supports stereo mode with an I²S data format and 256 fs master clock rate. It is recommended to use a weak pull-up resistor on CLATCH in applications that have a microcontroller. This pull-up resistor ensures that the AD1938 recognizes the presence of a microcontroller.

The SPI control port of the AD1938 is a 4-wire serial control port. The format is similar to the Motorola SPI format except the input data-word is 24 bits wide. The serial bit clock and latch can be completely asynchronous to the sample rate of the ADCs and DACs. Figure 11 shows the format of the SPI signal. The first byte is a global address with a read/write bit. For the AD1938, the address is 0x04, shifted left one bit due to the R/W bit. The second byte is the AD1938 register address and the third byte is the data.

Table 11. Standalone Word Selection						
ADC Clocks CIN COUT CCLK CLATCH						
Slave 0 0 0 0						
Master 0 1 0 0						



Figure 11. Format of SPI Signal

POWER SUPPLY AND VOLTAGE REFERENCE

The AD1938 is designed for 3.3 V supplies. Separate power supply pins are provided for the analog and digital sections. These pins should be bypassed with 100 nF ceramic chip capacitors, as close to the pins as possible, to minimize noise pickup. A bulk aluminum electrolytic capacitor of at least 22 μF should also be provided on the same PCB as the codec. For critical applications, improved performance is obtained with separate supplies for the analog and digital sections. If this is not possible, it is recommended that the analog and digital supplies be isolated by means of a ferrite bead in series with each supply. It is important that the analog supply be as clean as possible.

All digital inputs are compatible with TTL and CMOS levels. All outputs are driven from the 3.3 V DVDD supply and are compatible with TTL and 3.3 V CMOS levels.

The ADC and DAC internal voltage reference (VREF) is brought out on FILTR and should be bypassed as close as possible to the chip, with a parallel combination of 10 μ F and 100 nF. Any external current drawn should be limited to less than 50 μ A.

The internal reference can be disabled in the PLL and Clock Control 1 register, and FILTR can be driven from an external source. This configuration can be used to scale the DAC output to the clipping level of a power amplifier based on its power supply voltage. The ADC input gain varies by the inverse ratio. The total gain from ADC input to DAC output remains constant.

The CM pin is the internal common-mode reference. It should be by passed as close as possible to the chip, with a parallel combination of 47 μF and 100 nF. This voltage can be used to bias external op amps to the common-mode voltage of the input and output signal pins. The output current should be limited to less than 0.5 mA source and 2 mA sink.

SERIAL DATA PORTS—DATA FORMAT

The eight DAC channels use a common serial bit clock (DBCLK) and a common left-right framing clock (DLRCLK) in the serial data port. The four ADC channels use a common serial bit clock (ABCLK) and left-right framing clock (ALRCLK) in the serial data port. The clock signals are all synchronous with the sample rate. The normal stereo serial modes are shown in Figure 23.

The ADC and DAC serial data modes default to I²S. The ports can also be programmed for left-justified, right-justified, and TDM modes. The word width is 24 bits by default and can be programmed for 16 or 20 bits. The DAC serial formats are programmable according to the DAC Control 0 register. The polarity of the DBCLK and DLRCLK is programmable according to DAC Control 1 register. The ADC serial formats and serial clock polarity are programmable according to ADC Control 1 register. Both DAC and ADC serial ports are programmable to become the bus masters according to DAC Control 1 register

and ADC Control 2 register. By default, both ADC and DAC serial ports are in the slave mode.

TIME-DIVISION MULTIPLEXED (TDM) MODES

The AD1938 serial ports also have several different TDM serial data modes. The first and most commonly used configurations are shown in Figure 12 and Figure 13. In Figure 12, the ADC serial port outputs one data stream consisting of four on-chip ADCs followed by four unused slots. In Figure 13, the eight on-chip DAC data slots are packed into one TDM stream. In this mode, both DBCLK and ABCLK are 256 fs.

The I/O pins of the serial ports are defined according to the serial mode selected. For a detailed description of the function of each pin in TDM and auxiliary modes, see Table 12.

The AD1938 allows systems with more than eight DAC channels to be easily configured by the use of an auxiliary serial data port. The DAC TDM-AUX mode is shown in Figure 14. In this mode, the AUX channels are the last four slots of the TDM data stream. These slots are extracted and output to the AUX serial port. It should be noted that due to the high DBCLK frequency, this mode is available only in the 48 kHz/44.1 kHz/32 kHz sample rate.

The AD1938 also allows system configurations with more than four ADC channels as shown in Figure 15 and Figure 16 that show using 8 ADCs and 16 ADCs, respectively. Again, due to the high ABCLK frequency, this mode is available only in the 48 kHz/44.1 kHz/32 kHz sample rate.

Combining the AUX ADC and DAC modes results in a system configuration of 8 ADCs and 12 DACs. The system, then, consists of two external stereo ADCs, two external stereo DACs, and one AD1938. This mode is shown in Figure 17 (combined AUX ADC and DAC modes).



Mnemonic	Stereo Modes	TDM Modes	AUX Modes
ASDATA1	ADC1 Data Out	ADC TDM Data Out	TDM Data Out
ASDATA2	ADC2 Data Out	ADC TDM Data In	AUX Data Out 1 (to Ext. DAC 1)
DSDATA1	DAC1 Data In	DAC TDM Data In	TDM Data In
DSDATA2	DAC2 Data In	DAC TDM Data Out	AUX Data In 1 (from Ext. ADC 1)
DSDATA3	DAC3 Data In	DAC TDM Data In 2 (Dual-Line Mode)	AUX Data In 2 (from Ext. ADC 2)
DSDATA4	DAC4 Data In	DAC TDM Data Out 2 (Dual-Line Mode)	AUX Data Out 2 (to Ext. DAC 2)
ALRCLK	ADC LRCLK In/ADC LRCLK Out	ADC TDM Frame Sync In/DC TDM Frame Sync Out	TDM Frame Sync In/TDM Frame Sync Out
ABCLK	ADC BCLK In/ADC BCLK Out	ADC TDM BCLK In/ADC TDM BCLK Out	TDM BCLK In/TDM BCLK Out
DLRCLK	DAC LRCLK In/DAC LRCLK Out	DAC TDM Frame Sync In/DAC TDM Frame Sync Out	AUX LRCLK In/AUX LRCLK Out
DBCLK	DAC BCLK In/DAC BCLK Out	DAC TDM BCLK In/DAC TDM BCLK Out	AUX BCLK In/AUX BCLK Out





Data Sheet



AD1938

Data Sheet



Figure 17. Combined AUX DAC and ADC Mode

DAISY-CHAIN MODE

The AD1938 allows a daisy-chain configuration to expand the system to 8 ADCs and 16 DACs (see Figure 18). In this mode, the DBCLK frequency is 512 f_s . The first eight slots of the DAC TDM data stream belong to the first AD1938 in the chain and the last eight slots belong to the second AD1938. The second AD1938 is the device attached to the DSP TDM port.

To accommodate 16 channels at a 96 kHz sample rate, the AD1938 can be configured into a dual-line TDM mode as shown in Figure 19. This mode allows a slower DBCLK than normally required by the one-line TDM mode.

Again, the first four channels of each TDM input belong to the first AD1938 in the chain and the last four channels belong to the second AD1938.

The dual-line TDM mode can also be used to send data at a 192 kHz sample rate into the AD1938 as shown in Figure 20.

There are two configurations for the ADC port to work in daisy-chain mode. The first one is with an ABCLK at 256 fs shown in Figure 21. The second configuration is shown in Figure 22. Note that in the 512 fs ABCLK mode, the ADC channels occupy the first eight slots; the second eight slots are empty. The TDM_IN of the first AD1938 must be grounded in all modes of operation.

The I/O pins of the serial ports are defined according to the serial mode selected. See Table 13 for a detailed description of the function of each pin. See Figure 26 for a typical AD1938 configuration with two external stereo DACs and two external stereo ADCs.

Figure 23 through Figure 25 show the serial mode formats. For maximum flexibility, the polarity of LRCLK and BCLK are programmable. In these figures, all of the clocks are shown with their normal polarity. The default mode is I²S.



Figure 18. Single-Line DAC TDM Daisy-Chain Mode (Applicable to 48 kHz Sample Rate, 16-Channel, Two-AD1938 Daisy Chain)

Data Sheet DLRCLK MML DBCLK 8 DAC CHANNELS OF THE FIRST IC IN THE CHAIN 8 DAC CHANNELS OF THE SECOND IC IN THE CHAIN DSDATA1 (IN) DAC R1 DAC L2 DAC R2 DAC R1 DAC L2 DAC R2 DAC L1 DAC L1 ---------------DSDATA2 (OUT) DAC L1 DAC R1 DAC L2 DAC R2 DSDATA3 (IN) DAC L3 DAC R3 DAC L4 DAC R4 DAC L3 DAC R3 DAC L4 DAC R4 ---------------DSDATA4 (OUT) DAC L3 DAC R3 DAC L4 DAC R4 -----32 BITS MSB FIRST AD193x SECOND AD193x 05582-019 DSP Figure 19. Dual-Line DAC TDM Mode (Applicable to 96 kHz Sample Rate, 16-Channel, Two-AD1938 Daisy Chain); DSDATA3 and DSDATA4 Are the Daisy Chain DLRCLK DBCLK DSDATA1 DAC L1 DAC R1 DAC L2 DAC R2 DSDATA2 DAC R4 DAC L3 DAC R3 DAC L4 32 BITS 5582-020 MSB Figure 20. Dual-Line DAC TDM Mode (Applicable to 192 kHz Sample Rate, 8-Channel Mode) ALRCLK MML ABCLK 4 ADC CHANNELS OF SECOND IC IN THE CHAIN 4 ADC CHANNELS OF FIRST IC IN THE CHAIN ASDATA1 (TDM_OUT OF THE SECOND AD193x IN THE CHAIN) ADC L1 ADC R1 ADC L2 ADC R2 ADC L1 ADC R1 ADC L2 ADC R2

Rev. E | Page 20 of 32

Figure 21. ADC TDM Daisy-Chain Mode (256 fs BCLK, Two-AD193x Daisy Chain)

ADC R2

32 BITS

мѕв

05582-021

ASDATA2 (TDM_IN OF THE SECOND AD193x IN THE CHAIN)

FIRST

AD193x

ADC L1

SECOND AD193x

ADC R1

DSP

ADC L2





Figure 23. Stereo Serial Modes



Figure 25. ADC Serial Timing

Table 15. Fli	Table 15. Fill Function Changes in TDM and AOA Modes (Replication of Table 12)				
Mnemonic	Stereo Modes	TDM Modes	AUX Modes		
ASDATA1	ADC1 Data Out	ADC TDM Data Out	TDM Data Out		
ASDATA2	ADC2 Data Out	ADC TDM Data In	AUX Data Out 1 (to Ext. DAC 1)		
DSDATA1	DAC1 Data In	DAC TDM Data In	TDM Data In		
DSDATA2	DAC2 Data In	DAC TDM Data Out	AUX Data In 1 (from Ext. ADC 1)		
DSDATA3	DAC3 Data In	DAC TDM Data In 2 (Dual-Line Mode)	AUX Data In 2 (from Ext. ADC 2)		
DSDATA4	DAC4 Data In	DAC TDM Data Out 2 (Dual-Line Mode)	AUX Data Out 2 (to Ext. DAC 2)		
ALRCLK	ADC LRCLK In/ADC LRCLK Out	ADC TDM Frame Sync In/DC TDM Frame Sync Out	TDM Frame Sync In/TDM Frame Sync Out		
ABCLK	ADC BCLK In/ADC BCLK Out	ADC TDM BCLK In/ADC TDM BCLK Out	TDM BCLK In/TDM BCLK Out		
DLRCLK	DAC LRCLK In/DAC LRCLK Out	DAC TDM Frame Sync In/DAC TDM Frame Sync Out	AUX LRCLK In/AUX LRCLK Out		
DBCLK	DAC BCLK In/DAC BCLK Out	DAC TDM BCLK In/DAC TDM BCLK Out	AUX BCLK In/AUX BCLK Out		





Figure 26. Example of AUX Mode Connection to SHARC (AD1938 as TDM Master/AUX Master Shown)

CONTROL REGISTERS

DEFINITIONS

The global address for the AD1938 is 0x04, shifted left one bit due to the R/W bit. All registers are reset to 0, except for the DAC volume registers that are set to full volume.

Note that the first setting in each control register parameter is the default setting.

Table 14. Register Format

	Global Address	R/W	Register Address	Data
Bit	23:17	16	15:8	7:0

Table 15. Register Addresses and Functions

Address	Function
0	PLL and Clock Control 0
1	PLL and Clock Control 1
2	DAC Control 0
3	DAC Control 1
4	DAC Control 2
5	DAC individual channel mutes
6	DAC L1 volume control
7	DAC R1 volume control
8	DAC L2 volume control
9	DAC R2 volume control
10	DAC L3 volume control
11	DAC R3 volume control
12	DAC L4 volume control
13	DAC R4 volume control
14	ADC Control 0
15	ADC Control 1
16	ADC Control 2

PLL AND CLOCK CONTROL REGISTERS

Table 16. PLL and Clock Control Register 0 Description Bit Value Function 0 0 Normal operation PLL power-down 1 Power-down 2:1 00 MCLKI/XI pin functionality (PLL active), master clock rate setting INPUT 256 (× 44.1 kHz or 48 kHz) 01 INPUT 384 (× 44.1 kHz or 48 kHz) 10 INPUT 512 (× 44.1 kHz or 48 kHz) 11 INPUT 768 (× 44.1 kHz or 48 kHz) 4:3 00 XTAL oscillator enabled MCLKO/XO pin, master clock rate setting 01 $256 \times f_{S}$ VCO output 10 $512 \times f_{s}$ VCO output 11 Off MCLKI/XI 6:5 00 PLL input 01 DLRCLK 10 ALRCLK Reserved 11 0 Disable: ADC and DAC idle 7 Internal master clock enable 1 Enable: ADC and DAC active

Table 17. PLL and Clock Control Register 1

Bit	Value	Function	Description
0	0	PLL clock	DAC clock source select
	1	MCLK	
1	0	PLL clock	ADC clock source select
	1	MCLK	
2	0	Enabled	On-chip voltage reference
	1	Disabled	
3	0	Not locked	PLL lock indicator (read-only)
	1	Locked	
7:4	0000	Reserved	

DAC CONTROL REGISTERS

Table 18. DAC Control Register 0

Bit	Value	Function	Description
0	0	Normal	Power-down
	1	Power-down	
2:1	00	32 kHz/44.1 kHz/48 kHz	Sample rate
	01	64 kHz/88.2 kHz/96 kHz	
	10	128 kHz/176.4 kHz/192 kHz	
	11	Reserved	
5:3	000	1	SDATA delay (BCLK periods)
	001	0	
	010	8	
	011	12	
	100	16	
	101	Reserved	
	110	Reserved	
	111	Reserved	
7:6	00	Stereo (normal)	Serial format
	01	TDM (daisy chain)	
	10	DAC AUX mode (ADC-, DAC-, TDM-coupled)	
	11	Dual-line TDM	

Table 19. DAC Control Register 1

Bit	Value	Function	Description
0	0	Latch in mid cycle (normal)	BCLK active edge (TDM in)
	1	Latch in at end of cycle (pipeline)	
2:1	00	64 (2 channels)	BCLKs per frame
	01	128 (4 channels)	
	10	256 (8 channels)	
	11	512 (16 channels)	
3	0	Left low	LRCLK polarity
	1	Left high	
4	0	Slave	LRCLK master/slave
	1	Master	
5	0	Slave	BCLK master/slave
	1	Master	
6	0	DBCLK pin	BCLK source
	1	Internally generated	
7	0	Normal	BCLK polarity
	1	Inverted	

Table 20. DAC Control Register 2

Bit	Value	Function	Description
0	0	Unmute	Master mute
	1	Mute	
2:1	00	Flat	De-emphasis (32 kHz/44.1 kHz/48 kHz mode only)
	01	48 kHz curve	
	10	44.1 kHz curve	
	11	32 kHz curve	
4:3	00	24	Word width
	01	20	
	10	Reserved	
	11	16	
5	0	Noninverted	DAC output polarity
	1	Inverted	
7:6	00	Reserved	

Table 21. DAC Individual Channel Mutes

Bit	Value	Function	Description
0	0	Unmute	DAC 1 left mute
	1	Mute	
1	0	Unmute	DAC 1 right mute
	1	Mute	
2	0	Unmute	DAC 2 left mute
	1	Mute	
3	0	Unmute	DAC 2 right mute
	1	Mute	
4	0	Unmute	DAC 3 left mute
	1	Mute	
5	0	Unmute	DAC 3 right mute
	1	Mute	
6	0	Unmute	DAC 4 left mute
	1	Mute	
7	0	Unmute	DAC 4 right mute
	1	Mute	

Table 22. DAC Volume Controls

Bit	Value	Function	Description
7:0	0	No attenuation	DAC volume control
	1 to 254	-3/8 dB per step	
	255	Full attenuation	

ADC CONTROL REGISTERS

Table 23. ADC Control Register 0				
Bit	Value	Function	Description	
0	0	Normal	Power-down	
	1	Power down		
1	0	Off	High-pass filter	
	1	On		
2	0	Unmute	ADC L1 mute	
	1	Mute		
3	0	Unmute	ADC R1 mute	
	1	Mute		
4	0	Unmute	ADC L2 mute	
	1	Mute		
5	0	Unmute	ADC R2 mute	
	1	Mute		
7:6	00	32 kHz/44.1 kHz/48 kHz	Output sample rate	
	01	64 kHz/88.2 kHz/96 kHz		
	10	128 kHz/176.4 kHz/192 kHz		
	11	Reserved		

Table 24. ADC Control Register 1

Bit	Value	Function	Description
1:0	00	24	Word width
	01	20	
	10	Reserved	
	11	16	
4:2	000	1	SDATA delay (BCLK periods)
	001	0	
	010	8	
	011	12	
	100	16	
	101	Reserved	
	110	Reserved	
	111	Reserved	
6:5	00	Stereo	Serial format
	01	TDM (daisy chain)	
	10	ADC AUX mode (ADC-, DAC-, TDM-coupled)	
	11	Reserved	
7	0	Latch in mid cycle (normal)	BCLK active edge (TDM in)
	1	Latch in at end of cycle (pipeline)	

Bit	Value	Function	Description
0	0	50/50 (allows 32, 24, 20, or 16 bit clocks (BCLKs) per channel)	LRCLK format
	1	Pulse (32 BCLKs per channel)	
1	0	Drive out on falling edge (DEF)	BCLK polarity
	1	Drive out on rising edge	
2	0	Left low	LRCLK polarity
	1	Left high	
3	0	Slave	LRCLK master/slave
	1	Master	
5:4	00	64	BCLKs per frame
	01	128	
	10	256	
	11	512	
6	0	Slave	BCLK master/slave
	1	Master	
7	0	ABCLK pin	BCLK source
	1	Internally generated	

Table 25. ADC Control Register 2

ADDITIONAL MODES

The AD1938 offers several additional modes for board level design enhancements. To reduce the EMI in board level design, serial data can be transmitted without an explicit BCLK. See Figure 27 for an example of a DAC TDM data transmission mode that does not require high speed DBCLK. This configuration is applicable when the AD1938 master clock is generated by the PLL with the DLRCLK as the PLL reference frequency. To relax the requirement for the setup time of the AD1938 in cases of high speed TDM data transmission, the AD1938 can latch in the data using the falling edge of DBCLK. This effectively dedicates the entire BCLK period to the setup time. This mode is useful in cases where the source has a large delay time in the serial data driver. Figure 28 shows this pipeline mode of data transmission.

Both the BLCK-less and pipeline modes are available on the ADC serial data port.



APPLICATIONS CIRCUITS

Typical applications circuits are shown in Figure 29 through Figure 32. Figure 29 shows a typical ADC input filter circuit. Recommended loop filters for LR clock and master clock as the PLL reference are shown in Figure 30. Output filters for the DAC outputs are shown in Figure 31 and Figure 32 for the noninverting and inverting cases.



Figure 29. Typical ADC Input Filter Circuit



Figure 31. Typical DAC Output Filter Circuit (Single-Ended, Noninverting)



Figure 30. Recommended Loop Filters for LRCLK and MCLK PLL Reference



Figure 32. Typical DAC Output Filter Circuit (Single-Ended, Inverting)

OUTLINE DIMENSIONS



(ST-48) Dimensions shown in millimeters

ORDERING GUIDE

Model ^{1, 2, 3}	Temperature Range	Package Description	Package Option
AD1938YSTZ	-40°C to +105°C	48-Lead LQFP	ST-48
AD1938YSTZRL	–40°C to +105°C	48-Lead LQFP, 13" Tape and Reel	ST-48
AD1938WBSTZ	–40°C to +105°C	48-Lead LQFP	ST-48
AD1938WBSTZ-RL	-40°C to +105°C	48-Lead LQFP, 13" Tape and Reel	ST-48
EVAL-AD1938AZ		Evaluation Board	

 1 Z = RoHS Compliant Part.

² For the AD1938YSTZ, AD1938YSTZRL, AD1938WBSTZ, and AD1938WBSTZ-RL: single-ended output; SPI control port.

 3 W = Qualified for Automotive Applications.

AUTOMOTIVE PRODUCTS

The AD1938WBSTZ and AD1938WBSTZ-RL models are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models; therefore, designers should review the Specifications section of this data sheet carefully. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

NOTES

©2006–2013 Analog Devices, Inc. All rights reserved. Trademarks and registered trademarks are the property of their respective owners. D05582-0-2/13(E)



www.analog.com